

REGULATORY COMPLIANCE











ITEM DESCRIPTION

Spread Spectrum MEMS Clock Oscillators LVCMOS (CMOS) 3.3Vdc 4 Pad 5.0mm x 7.0mm Plastic Surface Mount (SMD)

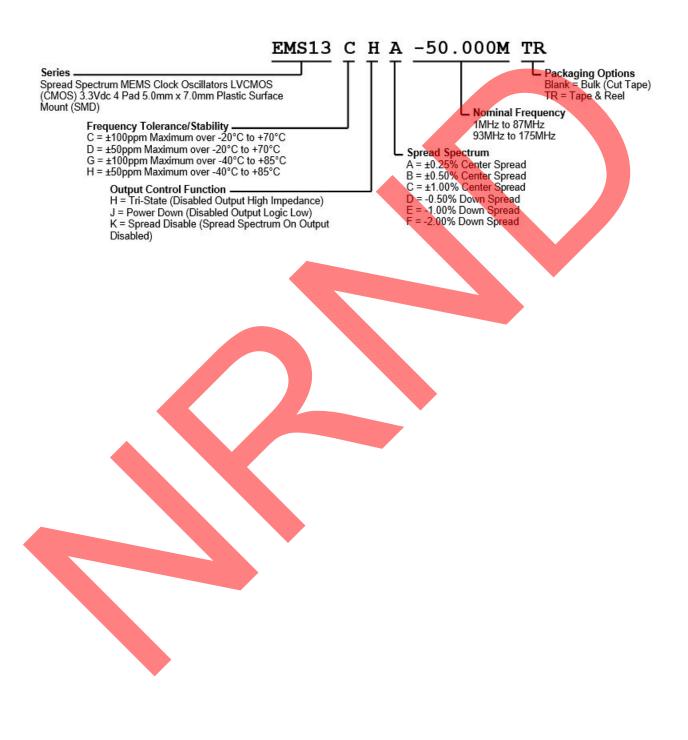
ELECTRICAL SPECIFICATIONS			
Nominal Frequency	1MHz to 175MHz		
Frequency Tolerance/Stability	Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C, 260°C Reflow, Shock, and Vibration ±100ppm Maximum over -20°C to +70°C ±50ppm Maximum over -20°C to +70°C ±100ppm Maximum over -40°C to +85°C ±50ppm Maximum over -40°C to +85°C		
Aging at 25°C	±1ppm Maximum First Year		
Supply Voltage	3.3Vdc ±10%		
Maximum Supply Voltage	-0.5Vdc to +3.65Vdc		
Input Current	Unloaded; Nominal Vdd 30mA Maximum over Nominal Frequency of 1MHz to 25MHz 40mA Maximum over Nominal Frequency of 25.000001MHz to 175MHz		
Output Voltage Logic High (V _{Oh})	IOH=-8mA 90% of Vdd Minimum		
Output Voltage Logic Low (Vol)	IOL=+8mA 10% of Vdd Maximum		
Rise/Fall Time	Measured from 20% to 80 <mark>% of w</mark> aveform 2nSec <mark>Maxi</mark> mum		
Duty Cycle	Measured at 50% of waveform 50 ±5(%) over Nominal Frequency of 1MHz to 75MHz 50 ±10(%) over Nominal Frequency of 75.000001MHz to 175MHz		
Load Drive Capability	15pF Maximum		
Output Logic Type	CMOS		
Output Control Function	Tri-State (Disabled Output - High Impedance) Power Down (Disabled Output - Logic Low) Spread Disable (Spread Spectrum On Output - Disabled)		
	7 <mark>0% of Vdd Minimum or No C</mark> onnection to Enable Output, 30% of Vdd Maximum to Disable Output (Disa <mark>bled Ou</mark> tput - Logic Low)		
Tri-State Input Voltage (Vih and Vil)	70% of Vdd Minimum or No Connection to Enable Output, 30% of Vdd Maximum to Disable Output (Disabled Output) - High Impedance)		
Standby Current	Pad 1=Ground 50μA Maximum (Disabled Output - Logic Low)		
Disable Current	Pad 1=Ground 20mA Maximum (Disabled Output - High Impedance)		
Spread Spectrum Input Voltage (Vih and Vil)	70% of Vdd Minimum or No Connection to Enable Spread Spectrum-On Output, 30% of Vdd Maximum to Disable Spread Spectrum-On Output		
Spread Spectrum	±0.25% Center Spread (Not available with Output Spread Disable Function) ±0.50% Center Spread (Not available with Output Spread Disable Function) ±1.00% Center Spread (Not available with Output Spread Disable Function) -0.50% Down Spread -1.00% Down Spread -2.00% Down Spread		
Modulation Frequency	30kHz Minimum, 32kHz Typical, 35kHz Maximum		
Period Jitter	Cycle to Cycle; Spread Spectrum-On; Fo=133.333M, Vdd=3.3Vdc 30pSec Maximum		
Start Up Time	10mSec Maximum		



Storage Temperature Range

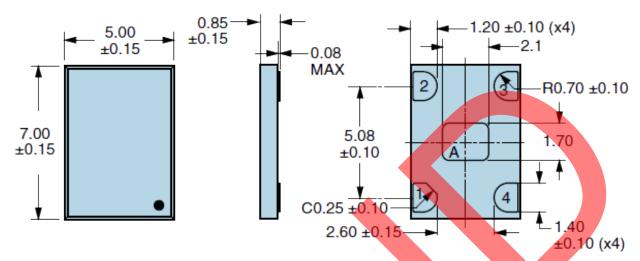
-55°C to +125°C

PART NUMBERING GUIDE



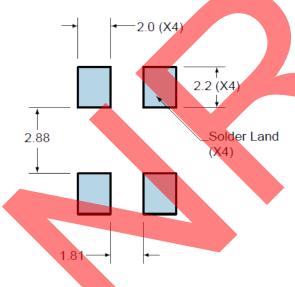


MECHANICAL DIMENSIONS



Note A: Center paddle is connected internally to oscillator ground (Pad 2).

SUGGESTED SOLDER PAD LAYOUT



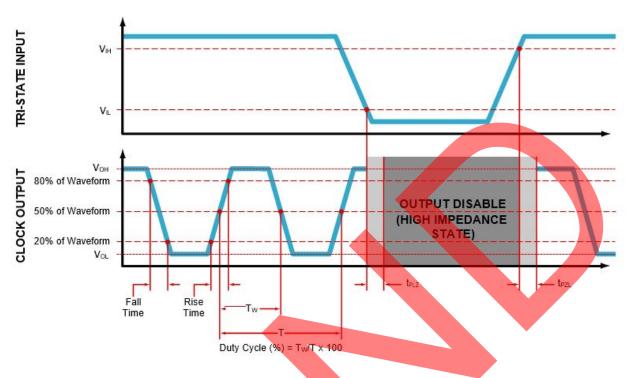
PIN	CONNECTION
1	Power Down (Logic Low) Or Spread Disable (Disabled) Or Tri-State (High Impedance)
2	Ground
3	Output
4	Supply Voltage

All Tolerances are ±0.1

All Dimensions in Millimeters

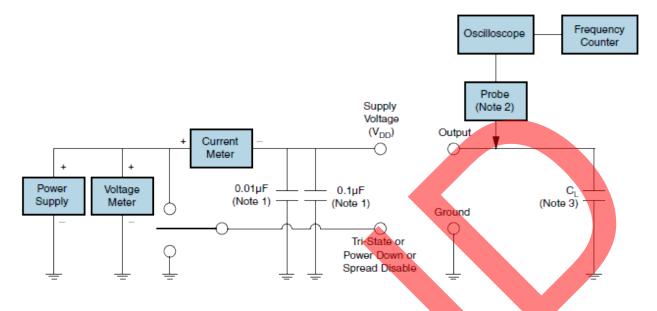


OUTPUT WAVEFORM & TIMING DIAGRAM





TEST CIRCUIT FOR CMOS OUTPUT



Note 1: An external 0.01µF ceramic bypass capacitor in parallel with a 0.1µF high frequency ceramic bypass capacitor close (less

than 2mm) to the package ground and supply voltage pin is required.

Note 2: A low capacitance (<12pF), 10X Attentuation Factor, High Impedance (>10Mohms), and High bandwidth (>300MHz) Passive probe is recommended.

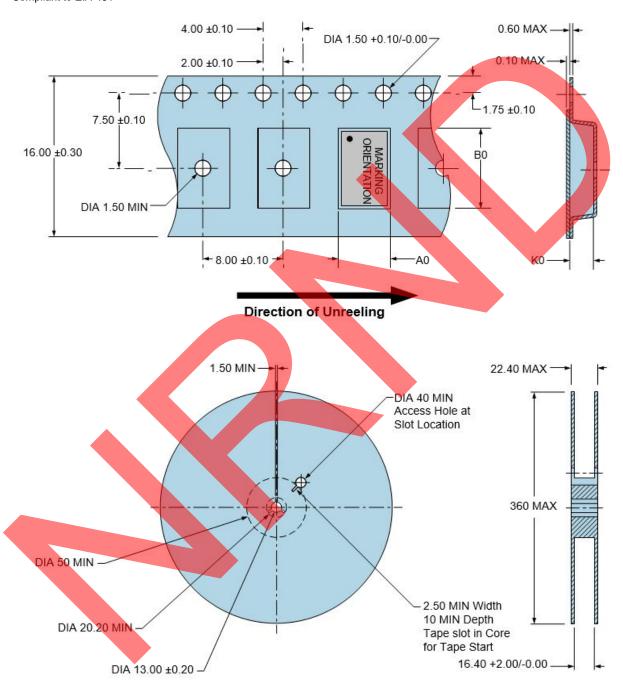
Note 3: Capacitance value (C_L) includes sum of all probe and fixture capacitance.



TAPE & REEL DIMENSIONS

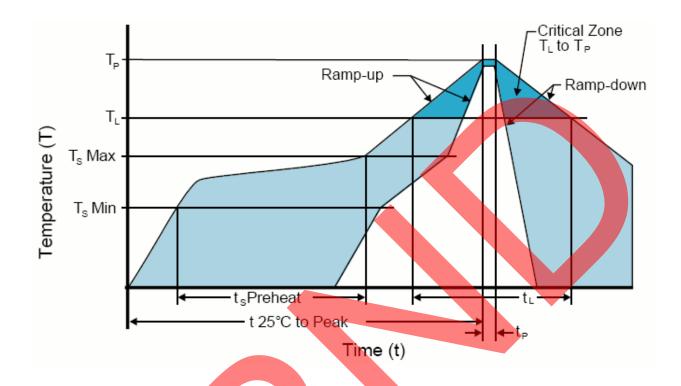
Quantity per Reel: 1,000 Units

All Dimensions in Millimeters
Compliant to EIA-481





RECOMMENDED SOLDER REFLOW METHOD



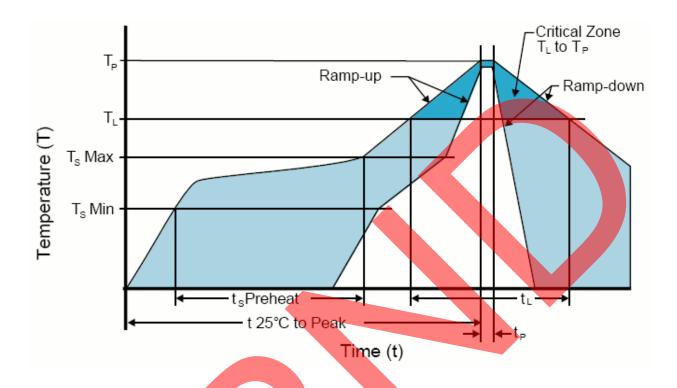
HIGH TEMPERATURE INFRARED/CONVECTION			
T _s MAX to T _L (Ramp-up Rate)	3°C/Second Maximum		
Preheat			
- Temperature Minimum (T _s MIN)	150°C		
- Temperature Typical (T _s TYP)	175°C		
- Temperature Maximum(T _s MAX)	200°C		
- Time (t _s)	60 - 180 Seconds		
Ramp-up Rate (T _L to T _P)	3°C/Second Maximum		
Time Maintained Above:			
- Temperature (T _L)	217°C		
- Time (t _L)	60 - 150 Seconds		
Peak Temperature (T _P)	260°C Maximum for 10 Seconds Maximum		
Target Peak Temperature(TP Target)	250°C +0/-5°C		
Time within 5°C of actual peak (tp)	20 - 40 Seconds		
Ramp-down Rate	6°C/Second Maximum		
Time 25°C to Peak Temperature (t)	8 Minutes Maximum		
Moisture Sensitivity Level	Level 1		
Additional Notes	Temperatures shown are applied to body of device.		

High Temperature Manual Soldering

260°C Maximum for 5 Seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)



RECOMMENDED SOLDER REFLOW METHOD



LOW TEMPERATURE INFRARED	CONVECTION CONVECTION
T _s MAX to T _L (Ramp-up Rate)	5°C/Second Maximum
Preheat	
- Temperature Minimum (T _s MIN)	N/A
- Temperature Typical (T _s TYP)	150°C
- Temperature Maximum(T _s MAX)	N/A
- Time (t _s)	60 - 120 Seconds
Ramp-up Rate (T _L to T _P)	5°C/Second Maximum
Time Maintained Above:	
- Temperature (T _L)	150°C
- Time (t _L)	200 Seconds Maximum
Peak Temperature (T _P)	240°C Maximum
Target Peak Temperature (T _P Target)	240°C Maximum 2 Times / 230°C Maximum 1 Time
Time within 5°C of actual peak (t₂)	10 Seconds Maximum 2 Times / 80 Seconds Maximum 1 Time
Ramp-down Rate	5°C/Second Maximum
Time 25°C to Peak Temperature (t)	N/A
Moisture Sensitivity Level	Level 1
Additional Notes	Temperatures shown are applied to body of device.

Low Temperature Manual Soldering

185°C Maximum for 10 Seconds Maximum, 2 times Maximum. (Temperatures shown are applied to body of device.)

Mouser Electronics

Authorized Distributor

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ABRACON:

<u>EMS13CHA-80.000M</u> <u>EMS13CKD-48.000M</u> <u>EMS13CKE-48.000M</u> <u>EMS13CKF-48.000M</u> <u>EMS13CHC-5.069M</u> EMS13CHA-50.000MHz <u>EMS13GHC-40.000M</u>